

<b>Notice of References Cited</b>	Application/Control No. 10/684,614	Applicant(s)/Patent Under Reexamination ONER ET AL	
	Examiner Tanh Q. Nguyen	Art Unit 2182	Page 1 of 2

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	Examiner Tanh Q. Nguyen	Art Unit 2182	Page 2 of 2

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